

<b>Notice of References Cited</b>		Application/Control No. 10/637,849	Applicant(s)/Patent Under Reexamination SHINKAI ET AL.	
		Examiner Brian E. Miller	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0176352	11-2002	Konno et al.	369/271
*	B	US-2002/0031077	03-2002	Shiwa, Masayuki	369/271
*	C	US-2002/0089918	07-2002	Watanabe et al.	369/270
*	D	US-5,555,233	09-1996	Yano et al.	720/709
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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